

# Three-dimensional Graphene Coated Shape Memory Polyurethane Foam with Fast Responsive Performance

Tianjiao Wang,<sup>a,b</sup> Jun Zhao,<sup>\*a,b</sup> Chuanxin Weng,<sup>a,b</sup> Tong Wang,<sup>a,b</sup> Yayun Liu,<sup>a</sup>  
Zhipeng Han,<sup>a,c</sup> and Zhong Zhang<sup>\*a,b</sup>

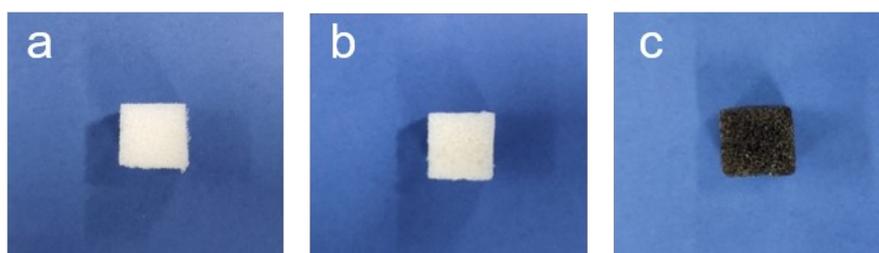
<sup>a</sup> CAS Key Laboratory of Nanosystem and Hierarchical Fabrication, CAS Center for Excellence in Nanoscience, National Center for Nanoscience and Technology, Beijing 100190, China

<sup>b</sup> University of Chinese Academy of Sciences, Beijing 100049, China

<sup>c</sup> Tianjin Key Laboratory of Molecular Optoelectronic Sciences, Department of Chemistry, School of Science, Tianjin University & Collaborative Innovation Center of Chemical Science and Engineering (Tianjin), Tianjin 300072, China

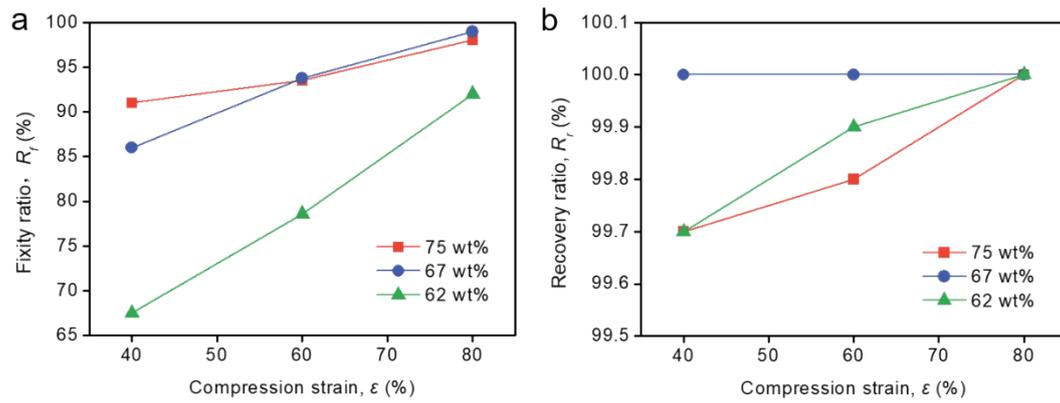
\* Corresponding authors: National Center for Nanoscience and Technology, Beijing 100190, China

E-mail: zhaoj@nanoctr.cn, zhong.zhang@nanoctr.cn

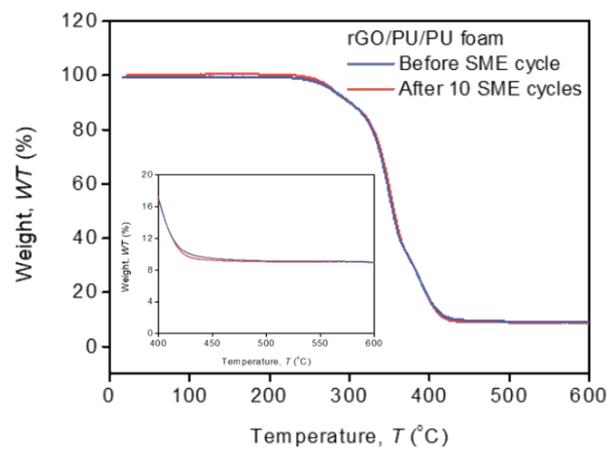


**Fig. S1** The digital photographs of PU foam (a), SMPU/PU foam (b) and rGO/SMPU/PU foam (c).

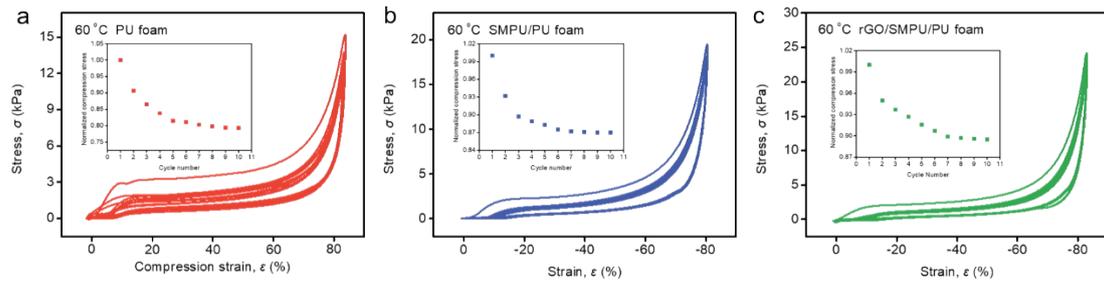




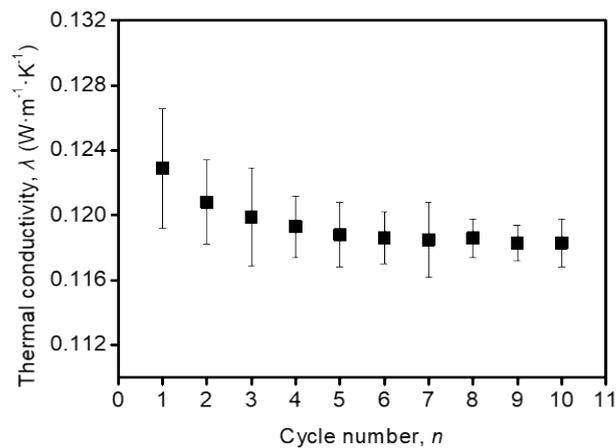
**Fig. S5** The shape fixity ratio (a) and shape recovery ratio (b) of SMPU/PU foams with different SMPU contents under compression strain of 40%, 60% and 80%, respectively.



**Fig. S6** The TGA curves of rGO/SMPU/PU foam before and after 10 SME cycles.

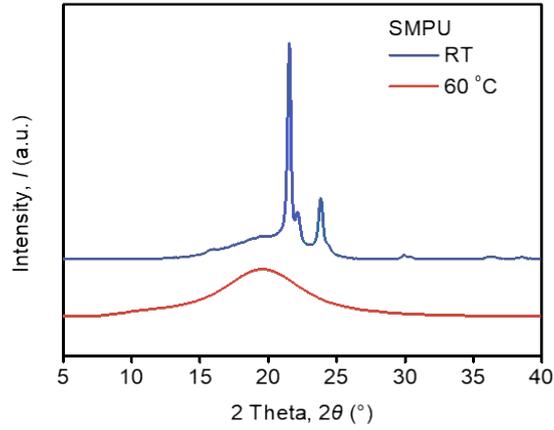


**Fig. S7** The cyclic stress-strain curves of 10 cycles of PU foam (a), SMPU/PU foam (b) and rGO/SMPU/PU foam (c) at 60 °C and 80% strain, respectively. The insets are the normalized compression stress in 10 cycles.



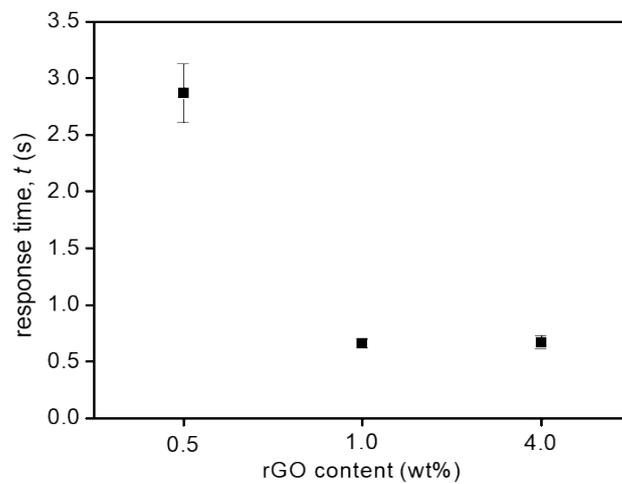
**Fig. S8** The thermal conductivity of rGO/SMPU/PU foam during 10 shape memory cycles at 25 °C.

As shown in **Fig. S8**, the thermal conductivity of rGO/SMPU/PU foam has good stable. It firstly decreases and then remains stable.



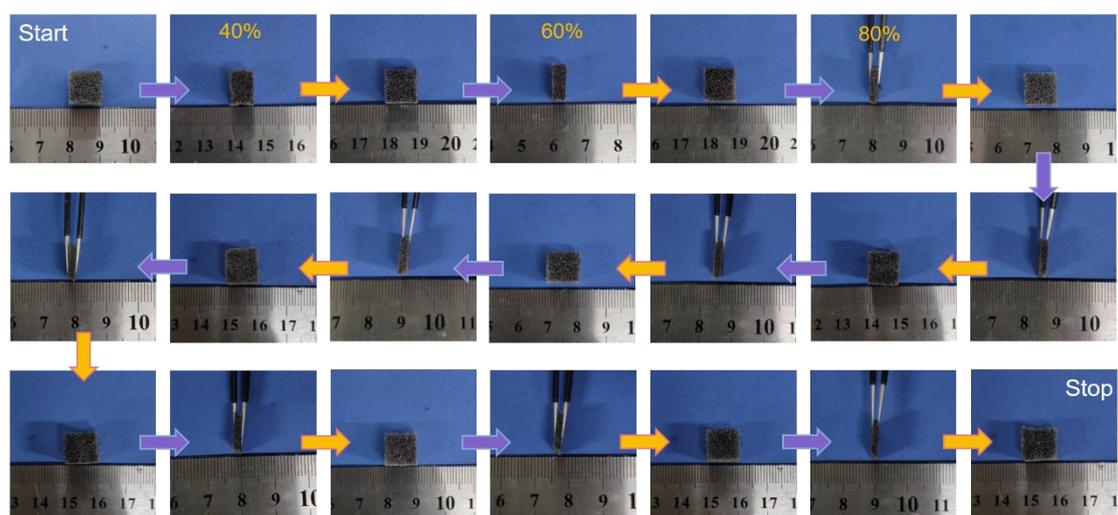
**Fig. S9** XRD curves for SMPU at RT and 60 °C.

Fig. S9 illustrates the crystallinity of SMPU at different temperatures. At room temperature (RT), two sharp diffraction peaks are located at 22° and 24°, and they belong to (110) and (200) crystallographic plane, respectively. When the temperature increases to 60 °C, two sharp diffraction peaks disappear, leaving a broad peak at 20°, which is attributed to the amorphous phase. The above results show that the crystals of SMPU are melted at 60 °C.



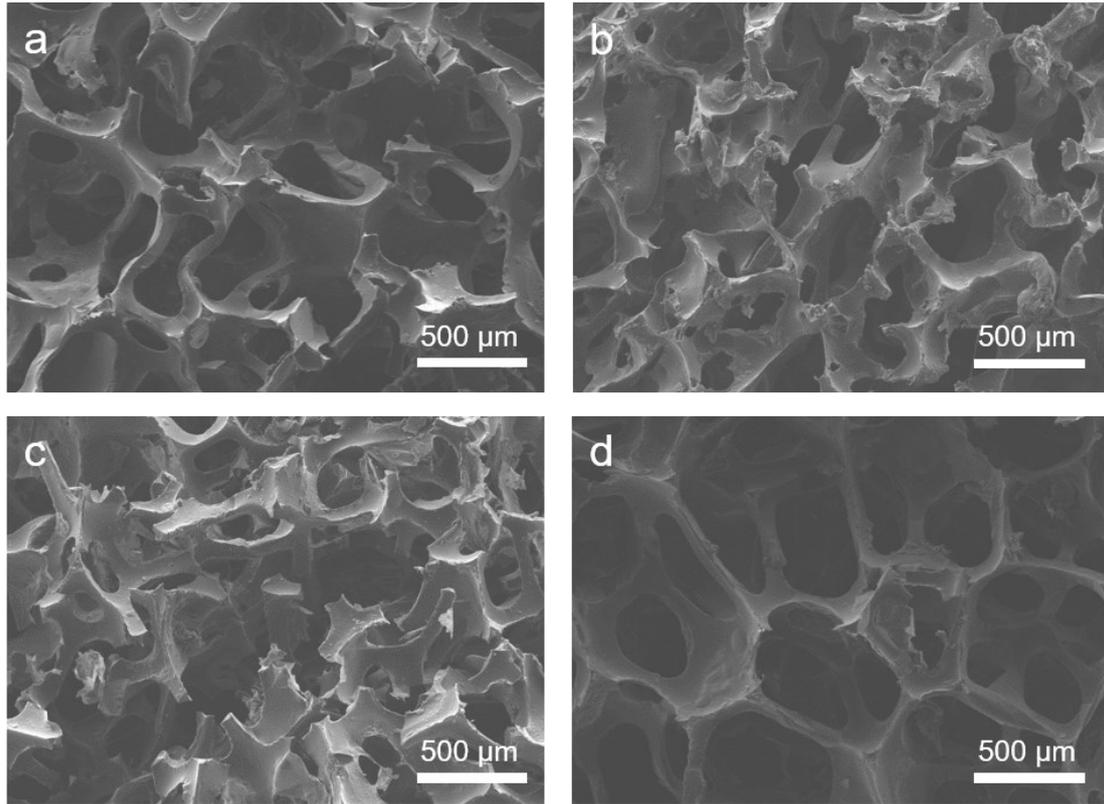
**Fig. S10** The effect of rGO content on the response time of rGO/SMPU/PU foam.

As shown in **Fig. S10**, when the rGO content increases from 0.5 wt% to 1.0 wt%, the response time of rGO/SMPU/PU foam decreases rapidly from 2.87 s to 0.66 s. Moreover, when the rGO content further increases to 4.0 wt%, the response time does not decrease any more.



**Fig. S11** The photographs of rGO/SMPU/PU foam with 10 shape memory cycles.

As shown in **Fig. S11**, the rGO/SMPU/PU foam exhibit good shape memory performance. The shape fixity ratio of the rGO/SMPU/PU foam under 80 % compression strain is about  $98.95\% \pm 0.03\%$  and the shape recovery ratio is always 100% during 10 shape memory cycles.



**Fig. S12** The cross-sectional SEM images of rGO/SMPU/PU foams with 40% strain (a), 60% strain (b), 80% strain (c) and shape recovery (d).

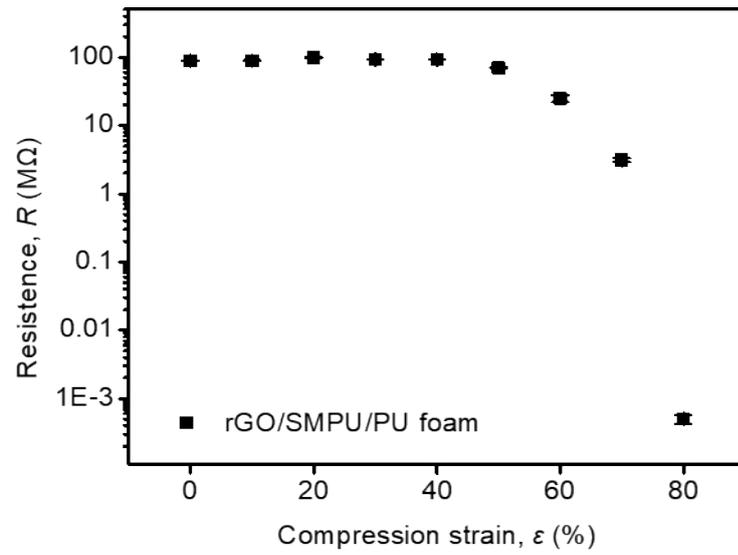
**Table S1** Shape memory performance of various SMPs.

Materials	Stimuli	Recovery time (s)	Recovery ratio (%)	Reference
PGEC composite	electricity	150	96	38
NIPAM hydrogels	solvent	10	98	8
TPI-graphene-PAAm composites	electricity	7	99	28

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PNIPAM/PPY	solvent	10	99	7
hydrogels				
CB@CNC/NR@PU	solvent	3-12	100	39
CNT/SMP	electricity	10	98	32
Graphene-CNT/PU	heat	23-40	79-90	27
CNT/EVA	heat	20	90	25
AgNWs/MF/Epoxy	electricity	25	99	16
PLA-PEG	light	7200	58-80	5
PVA hydrogels	heat	600	80	4
PECU/CNC	solvent	1800	85	40
PEG-PCL-CNC	solvent	300	90	41
CB/PU	light	125-350	78-100	20
dPTB-mfGO	light	25	96	20
dPTB-mfGO	heat	342	96	20
dPTD-mfGO	light	28	93	20
dPTD-mfGO	heat	390	93	20
dPTD-GO	light	65	69	20
dPTD-GO	heat	485	69	20
SMPU/PU foam	heat	< 5s	100	This work
rGO/SMPU/PU foam	heat	< 1s	100	This work

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**Fig. S13** Variation of resistance change concerning compression strain for rGO/SMPU/PU foam.